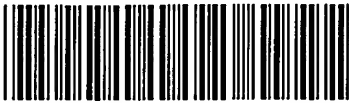


Search Notes

Application/Control No.

10/669,347

Examiner

Sang Nguyen

Applicant(s)/Patent under
Reexamination

NAKANO, TAKAHIKO

Art Unit

2877

SEARCHED

Class	Subclass	Date	Examiner
356	601-624	6/2/2005	SN
250	559.23	↓	↓
↓	559.31		
	559.38		
	201		
	205		
	208.1		
	208.2	6/2/2005	SN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/2/2005	SN